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Fairchild Semiconductor 74F899QC

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February 1989 Revised August 1999

74F899

9-Bit Latchable Transceiver with Parity Generator/Checker

General Description

The 74F899 is a 9-bit to 9-bit parity transceiver with transparent latches. The device can operate as a feed-through transceiver or it can generate/check parity from the 8-bit data busses in either direction. It has a guaranteed current sinking capability of 24 mA at the A-bus and 64 mA at the B-bus.

The 74F899 features independent latch enables for the A-to-B direction and the B-to-A direction, a select pin for ODD/EVEN parity, and separate error signal output pins for checking parity.

Features

- Latchable transceiver with output sink of 24 mA at the A-bus and 64 mA at the B-bus
- Option to select generate parity and check or "feed-through" data/parity in directions A-to-B or B-to-A
- Independent latch enables for A-to-B and B-to-A directions
- Select pin for ODD/EVEN parity
- ERRA and ERRB output pins for parity checking
- Ability to simultaneously generate and check parity
- May be used in systems applications in place of the 74F543 and 74F280
- May be used in system applications in place of the 74F657 and 74F373 (no need to change T/R to check parity)

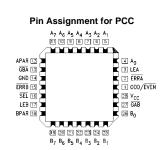
Ordering Code:

Order Number	Package Number	Package Description
74F899SC	M28B	28-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F899QC	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square

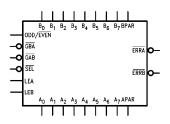
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams





Logic Symbol



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Input Loading/Fan-Out

		HIC	SH/LOW	
Pin Names	Description	U.L.	Input I _{IH} /I _{IL}	
		HIGH/LOW	Output I _{OH} /I _{OL}	
A ₀ -A ₇	Data Inputs/	1.0/1.0	20 μA/–0.6 mA	
	Data Outputs	150/40	−3 mA/24 mA	
B ₀ –B ₇	Data Inputs/	1.0/1.0	20 μA/–0.6 mA	
	Data Outputs	600/106.6	-12 mA/64 mA	
APAR	A Bus Parity	1.0/1.0	20 μA/–0.6 mA	
	Input/Output	150/40	−3 mA/24 mA	
BPAR	B Bus Parity	1.0/1.0	20 μA/-0.6 mA	
	Input/Output	600/106.6	–12 mA/64 mA	
ODD/EVEN	Parity Select Input	1.0/1.0	20 μA/-0.6 mA	
GBA, GAB	Output Enable Inputs	1.0/1.0	20 μA/-0.6 mA	
SEL	Mode Select Input	1.0/1.0	20 μA/-0.6 mA	
LEA, LEB	Latch Enable Inputs	1.0/1.0	20 μA/–0.6 mA	
ERRA, ERRB	Error Signal Outputs	50/33.3	−1 mA/20 mA	

Pin Descriptions

Pin Names	Description
A ₀ -A ₇	A Bus Data Inputs/Data Outputs
B ₀ –B ₇	B Bus Data Inputs/Data Outputs
APAR, BPAR	A and B Bus Parity Inputs
ODD/EVEN	ODD/EVEN Parity Select, Active LOW for EVEN Parity
GBA, GAB	Output Enables for A or B Bus, Active LOW
SEL	Select Pin for Feed-Through or Generate Mode, LOW for Generate Mode
LEA, LEB	Latch Enables for A and B Latches, HIGH for Transparent Mode
ERRA, ERRB	Error Signals for Checking Generated Parity with Parity In, LOW if Error Occurs

Functional Description

The 74F899 has three principal modes of operation which are outlined below. These modes apply to both the A-to-B and B-to-A directions.

- Bus A (B) communicates to Bus B (A), parity is generated and passed on to the B (A) Bus as BPAR (APAR). If LEB (LEA) is HIGH and the Mode Select ($\overline{\text{SEL}}$) is LOW, the parity generated from $\underline{\text{B[0:7]}}$ (A[0:7]) can be checked and monitored by ERRB (ERRA).
- Bus A (B) communicates to Bus B (A) in a feed-through mode if <u>SEL</u> is <u>HIGH</u>. Parity is still generated and checked as <u>ERRA</u> and <u>ERRB</u> in the feed-through mode (can be used as an interrupt to signal a data/parity bit error to the CPU).
- Independent Latch Enables (LEA and LEB) allow other permutations of generating/checking (see Function Table).



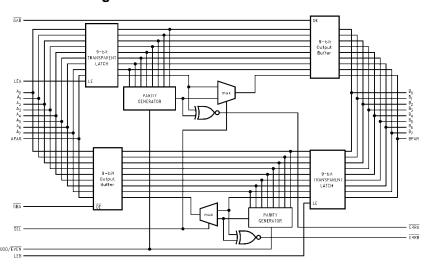
Function Table

Inputs GAB GBA SEL LEA LEB								
		LEB	Operation					
Н	Н	Х	Х	Х	Busses A and B are 3-STATE.			
Н	L	L	L	Н	Generates parity from B[0:7] based on O/ \overline{E} (Note 1). Generated parity \to APAR. Generated parity checked against BPAR and output as \overline{ERRB} .			
Н	L	L	Н	Н	Generates parity from B[0:7] based on O/ \overline{E} . Generated parity \rightarrow APAR. Generated parity checked against BPAR and output as \overline{ERRB} . Generated parity also fed back through the A latch for generate/check as \overline{ERRA} .			
Н	L	L	Х	L	Generates parity from B latch data based on O/E. Generated parity → APAR. Generated parity checked against latched BPAR and output as ERRB.			
Н	L	Н	Х	Н	BPAR/B[0:7] \rightarrow APAR/A0:7] Feed-through mode. Generated parity checked against BPAR and output as ERRB.			
Н	L	Н	Н	Н	$BPAR/B[0:7] \to APAR/A[0:7]$			
					Feed-through mode. Generated parity checked against BPAR and output <u>as ERRB.</u> Generated parity also fed back through the A latch for generate/check as ERRA.			
L	Н	L	Н	L	Generates parity for A[0:7] based on O/\overline{E} . Generated parity \to BPAR. Generated parity checked against APAR and output as \overline{ERRA} .			
L	Н	L	Н	Н	Generates parity from A[0:7] based on O/ \overline{E} . Generated parity \rightarrow BPAR. Generated parity checked against APAR and output as \overline{ERRA} . Generated parity also fed back through the B latch for generate/check as \overline{ERRB} .			
L	Н	L	L	Х	Generates parity from A latch data based on O/E. Generated parity → BPAR. Generated parity checked against latched APAR and output as ERRA.			
L	Н	Н	Н	L	$APAR/A[0:7] \to BPAR/B[0:7]$			
					Feed-through mode. Generated parity checked against APAR and output as ERRA.			
L	Н	Н	Н	Н	$APAR/A[0:7] \to BPAR/B[0:7]$			
					Feed-through mode. Generated parity checked against APAR and output <u>as ERRA</u> . Generated parity also fed back through the B latch for generate/check as ERRB.			

H = HIGH Voltage Level Note 1: $O/\overline{E} = ODD/\overline{EVEN}$ L = LOW Voltage Level

X = Immaterial

Functional Block Diagram





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Absolute Maximum Ratings(Note 2)

Recommended Operating Conditions

Storage Temperature Ambient Temperature under Bias -55°C to +125°C Junction Temperature under Bias -55°C to +150°C -0.5V to +7.0V

V_{CC} Pin Potential to Ground Pin Input Voltage (Note 3) -0.5V to +7.0V Input Current (Note 3) -30 mA to +5.0 mA

Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$)

Standard Output -0.5V to $V_{\mbox{\footnotesize CC}}$ 3-STATE Output -0.5V to +5.5V

Current Applied to Output

ESD Last Passing Voltage (Min)

in LOW State (Max) Twice the Rated I_{OL} (mA) Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 2: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 3: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	ool Parameter		Parameter Min Typ		Max	Units	V _{CC}	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a
								HIGH Signal
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a
								LOW Signal
V _{CD}	Input Clamp Diode	Ŭ			-1.2	V	Min	$I_{IN} = -18 \text{ mA}$
V _{OH}	Output HIGH	10% V _{CC}	2.5					I _{OH} = -1 mA
	Voltage	10% V _{CC}	2.4					$I_{OH} = -3 \text{ mA}$
		10% V _{CC}	2.0			V		$I_{OH} = -15 \text{ mA } (B_n, BPAR)$
		5% V _{CC}	2.7					$I_{OH} = -1 \text{ mA}$
		5% V _{CC}	2.7					$I_{OH} = -3 \text{ mA}$
V _{OL}	Output LOW	10% V _{CC}			0.5			I _{OL} = 20 mA
	Voltage							(A _n , APAR, ERRA, ERRB)
		5% V _{CC}			0.55	V		I _{OL} = 24 mA
								(A _n , APAR, ERRA, ERRB)
		10% V _{CC}			0.55			I _{OL} = 64 mA (B _n , BPAR)
V _{TH}	Input Threshold Voltage			1.45		V		±0.1V, Sweep Edge Rate must be > 1V/50 ns
V _{OLV}	Negative Ground Bounce					V		Observed on "quiet" output during
OLV	Voltage			1.0	1.0			simultaneous switching of remaining outputs
V _{OLP}	· ·							Observed on "quiet" output during
OLI	Voltage			1.0		V		simultaneous switching of remaining outputs
I _{IL}	Input Low Current				-0.6	mA	Max	V _{IN} = 0.5V
T _{IH}	Input HIGH							
	Current				5.0	μA	Max	$V_{IN} = 2.7V$
I _{BVI}	Input HIGH Curren	t						V _{IN} = 7.0V
	Breakdown Test				7.0	μΑ	Max	(ODD/EVEN, GBA, GAB, SEL, LEA, LEB)
I _{BVIT}	Input HIGH Curren	t						V _{IN} = 5.5V
DVII	Breakdown (I/O)				0.5	mA	Max	$(A_n, B_n, A_{PAR}, B_{PAR})$
I _{CEX}	Output HIGH							
OLX	Leakage Current				50	μΑ	Max	$V_{OUT} = V_{CC}$
V _{ID}	Input Leakage							I _{ID} = 1.9 μA
	Test		4.75			V	0.0	All Other Pins Grounded
I _{OD}	Output Leakage							V _{IOD} = 150 mV
	Circuit Current				3.75	μA	0.0	All Other Pins Grounded
I _{IL}	Input Low Current				-0.6	mA	Max	V _{IN} = 0.5V
T _{IH+}	Output Leakage Cu	urrent			=-		l	V _{I/O} = 2.7V
I _{OZH}	Current				70	μА	Max	(A _n , B _n , APAR, BPAR)
	I.		1			1		*

4000V

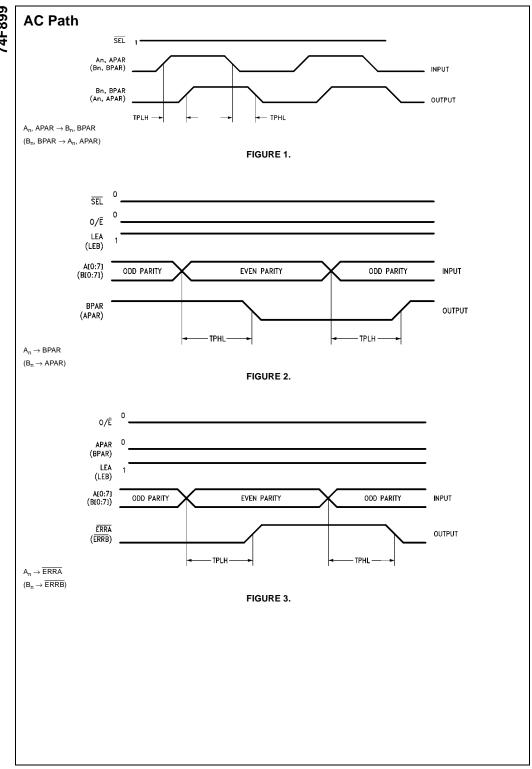


DC Electrical Characteristics (Continued)

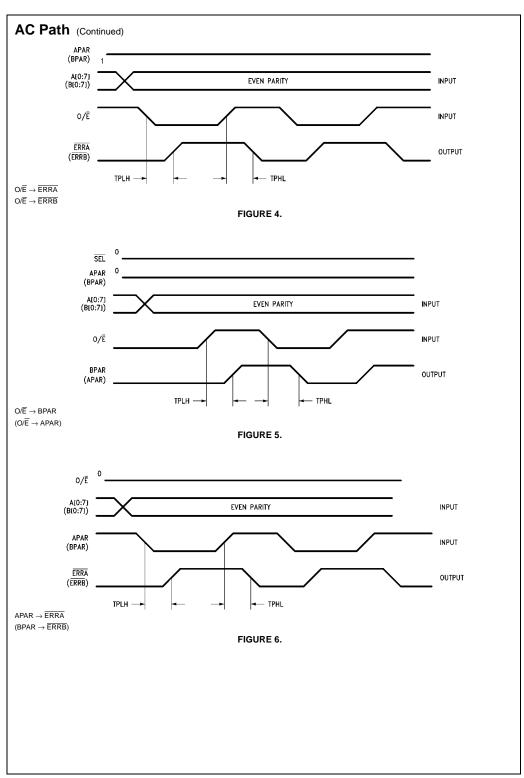
Symbol	Parameter	Min	Тур	Max	Units	v _{cc}	Conditions
I _{IL+}	Output Leakage			-650		Max	V _{I/O} = 0.5V
I _{OZL}	Current			-630	μΑ	IVIAX	(A _n , B _n , APAR, BPAR)
Ios	Output Short-Circuit Current	-60		-150		Max	V _{OUT} = 0V
					mA		(A _n , APAR, ERRA, ERRB)
		-100		-225		Max	$V_{OUT} = 0V (B_n, BPAR)$
I _{ZZ}	Bus Drainage Test			500	μΑ	0.0V	V _{OUT} = 5.25V
I _{CCH}	Power Supply Current		132	155	mA	Max	V _O = HIGH
I _{CCL}	Power Supply Current		178	210	mA	Max	V _O = LOW, GAB = LOW,
							GBA = HIGH, V _{IL} = LOW
I _{CCZ}	Power Supply Current		160	190	mA	Max	V _O = HIGH Z

AC Electrical Characteristics

			T _A = +25°C		T _A = 0°C	to +70°C		
Symbol	Parameter		V _{CC} = +5.0\	<i>I</i>	V _{CC} =	+5.0V	Heite	Figure
			C _L = 50 pF		C _L = 50 pF		Units	Number
		Min	Тур	Max	Min	Max		
t _{PLH}	Propagation Delay	4.0	7.5	13.0	4.0	14.0	ns	Figure 1
t _{PHL}	A _n , APAR to B _n , BPAR	4.0	8.5	13.0	4.0	14.0	115	Figure 1
t _{PLH}	Propagation Delay	7.5	12.0	17.0	7.5	18.0	ns	Figure 2
t _{PHL}	A _n , B _n to BPAR, APAR	7.5	12.5	17.0	7.5	18.0	115	1 igule 2
t _{PLH}	Propagation Delay	7.5	12.0	17.0	7.5	18.0	no	Figure 3
t_{PHL}	A _n , B _n to ERRA, ERRB	7.5	12.5	17.0	7.5	18.0	ns	Figure 3
t _{PLH}	Propagation Delay	4.5	7.5	11.0	4.5	12.0		Figure 4
t _{PHL}	ODD/EVEN to ERRA, ERRB	4.5	8.0	11.0	4.5	12.0	ns	Figure 4
t _{PLH}	Propagation Delay	4.5	7.5	11.5	4.5	12.5		
t _{PHL}	ODD/EVEN to APAR, BPAR	4.5	8.5	11.5	4.5	12.5	ns	Figure 5
t _{PLH}	Propagation Delay	5.5	9.0	13.0	5.5	14.0		F
t _{PHL}	APAR, BPAR to ERRA, ERRB	5.5	9.5	13.0	5.5	14.0	ns	Figure 6
t _{PLH}	LEA/LEB to	9.5	13.0	17.5	7.5	18.0		
t _{PHL}	ERRA /ERRB	9.7		17.5	7.5	18.0	ns	Figure 7
t _{PLH}	Propagation Delay	3.0	6.0	10.0	3.0	11.0		<u> </u>
t _{PHL}	SEL to APAR, BPAR	3.0	7.0	10.0	3.0	11.0	ns	Figure 10
t _{PLH}	Propagation Delay	3.5	7.0	10.0	3.5	11.0		Cierra 44
t _{PHL}	LEB to A _n , APAR	3.5	8.0	10.0	3.5	11.0	ns	Figure 11
t _{PLH}	Propagation Delay	3.5	6.5	10.0	3.5	11.0	no	Figure 11
t _{PHL}	LEA to B _n , BPAR	3.5	7.5	10.0	3.5	11.0	ns	Figure 11
t _{PZH}	Output Enable Time	1.0	4.5	10.0	1.0	11.0		
t_{PZL}	GBA or GAB to A _n ,	1.0	6.5	10.0	1.0	11.0	ns	Figure 8, Figure 9
	APAR or B _n , BPAR							. iguio o
t _{PHZ}	Output Disable Time	1.0	4.0	7.0	1.0	8.0		
t _{PLZ}	GBA or GAB to A _n ,	1.0	4.0	7.0	1.0	8.0	ns	Figure 8, Figure 9
	APAR or B _n , BPAR							1 iguie 3
t _S (H)	Setup Time, HIGH or LOW	5.0	1.6		5.0			Figure 12,
t _S (L)	A _n , B _n to LEA, LEB	5.0	1.8		5.0		ns	Figure 13
t _H (H)	Hold Time, HIGH or LOW	0	-1.7		0		no	Figure 12,
t _H (L)	A _n , B _n to LEA, LEB	0	-1.5		0		ns	Figure 13
t _W	Pulse Width for LEA, LEB	6.0	2.0		6.0		ns	Figure 14

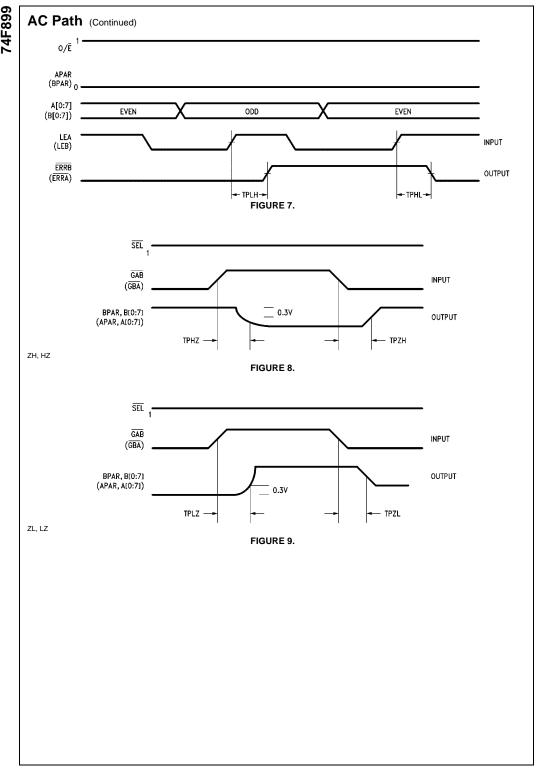


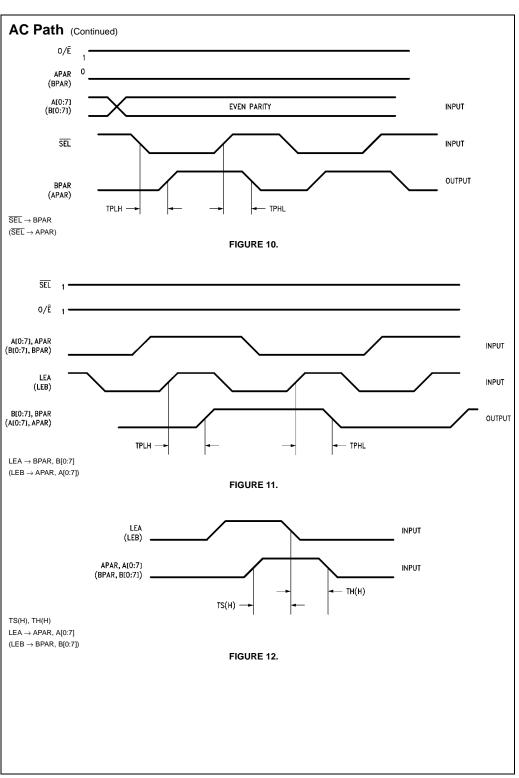
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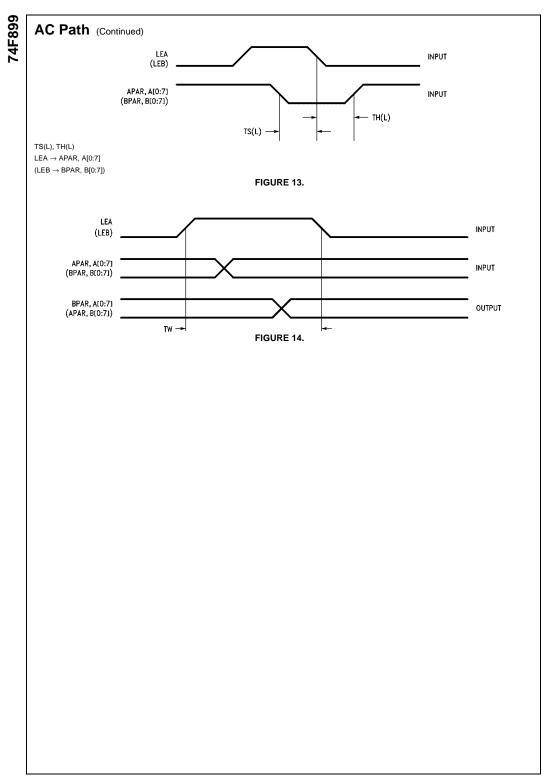
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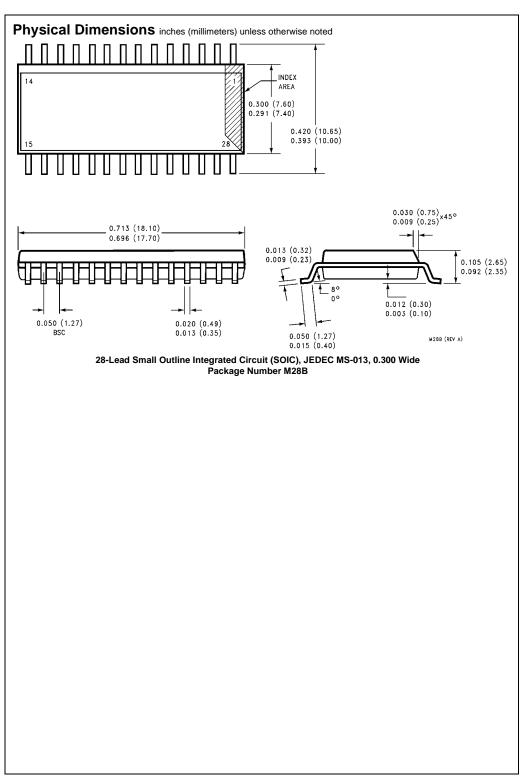


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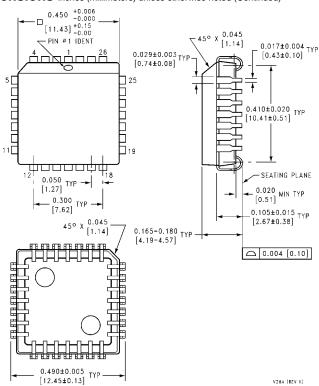


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74F899 9-Bit Latchable Transceiver

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Package Number V28A

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